

Power MOSFET

PRODUCT SUMMARY

| | | |
|----------------------------|-----------------|------|
| V_{DS} (V) at T_J max. | 560 V | |
| $R_{DS(on)}$ (Ω) | $V_{GS} = 10$ V | 0.38 |
| Q_g (Max.) (nC) | 68 | |
| Q_{gs} (nC) | 17.6 | |
| Q_{gd} (nC) | 21.8 | |
| Configuration | Single | |

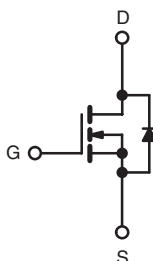
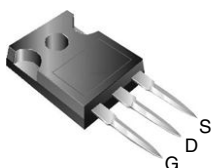
FEATURES

- Low Figure-of-Merit $R_{on} \times Q_g$
- 100 % Avalanche Tested
- Gate Charge Improved
- T_{rr}/Q_{rr} Improved
- Compliant to RoHS Directive 2002/95/EC



Available
RoHS*
COMPLIANT

TO-247AC



N-Channel MOSFET

ORDERING INFORMATION

| | |
|----------------|---------------|
| Package | TO-247AC |
| Lead (Pb)-free | SiHG16N50C-E3 |

ABSOLUTE MAXIMUM RATINGS $T_C = 25$ °C, unless otherwise noted

| PARAMETER | | | SYMBOL | LIMIT | UNIT |
|---|-------------------------|-------------------------|-----------------------------------|---------------|------|
| Drain-Source Voltage | | | V _{DS} | 500 | V |
| Gate-Source Voltage | | | V _{GS} | ± 30 | |
| Continuous Drain Current (T _J = 150 °C) ^a | V _{GS} at 10 V | T _C = 25 °C | I _D | 16 | A |
| | | T _C = 100 °C | | 10 | |
| Pulsed Drain Current ^c | | | I _{DM} | 40 | |
| Linear Derating Factor | | | | 2 | W/°C |
| Single Pulse Avalanche Energy ^b | | | E _{AS} | 320 | mJ |
| Maximum Power Dissipation | | | P _D | 250 | W |
| Operating Junction and Storage Temperature Range | | | T _J , T _{stg} | - 55 to + 150 | °C |
| Soldering Recommendations (Peak Temperature) ^d | for 10 s | | | 300 | |

Notes


- Limited by maximum junction temperature.
- $V_{DD} = 50$ V, starting $T_J = 25$ °C, $L = 2.5$ mH, $R_g = 25$ Ω , $I_{AS} = 16$ A.
- Repetitive rating; pulse width limited by maximum junction temperature.
- 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

THERMAL RESISTANCE RATINGS

| PARAMETER | SYMBOL | TYP. | MAX. | UNIT |
|----------------------------------|------------|------|------|------|
| Maximum Junction-to-Ambient | R_{thJA} | - | 40 | °C/W |
| Maximum Junction-to-Case (Drain) | R_{thJC} | - | 0.5 | |

SPECIFICATIONS $T_J = 25\text{ °C}$, unless otherwise noted

| PARAMETER | SYMBOL | TEST CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--|---------------------|---|------|-------|-----------|---------------|
| Static | | | | | | |
| Drain-Source Breakdown Voltage | V_{DS} | $V_{GS} = 0\text{ V}$, $I_D = 250\text{ }\mu\text{A}$ | 500 | - | - | V |
| V_{DS} Temperature Coefficient | $\Delta V_{DS}/T_J$ | Reference to 25 °C , $I_D = 1\text{ mA}$ | - | 0.6 | - | V/°C |
| Gate-Source Threshold Voltage (N) | $V_{GS(th)}$ | $V_{DS} = V_{GS}$, $I_D = 250\text{ }\mu\text{A}$ | 3.0 | - | 5.0 | V |
| Gate-Source Leakage | I_{GSS} | $V_{GS} = \pm 30\text{ V}$ | - | - | ± 100 | nA |
| Zero Gate Voltage Drain Current | I_{DSS} | $V_{DS} = 500\text{ V}$, $V_{GS} = 0\text{ V}$ | - | - | 50 | μA |
| | | $V_{DS} = 400\text{ V}$, $V_{GS} = 0\text{ V}$, $T_J = 125\text{ °C}$ | - | - | 250 | |
| Drain-Source On-State Resistance | $R_{DS(on)}$ | $V_{GS} = 10\text{ V}$, $I_D = 8\text{ A}$ | - | 0.317 | 0.38 | Ω |
| Forward Transconductance ^a | g_{fs} | $V_{DS} = 50\text{ V}$, $I_D = 3\text{ A}$ | - | 3 | - | S |
| Dynamic | | | | | | |
| Input Capacitance | C_{iss} | $V_{GS} = 0\text{ V}$, $V_{DS} = 25\text{ V}$, $f = 1.0\text{ MHz}$ | - | 1900 | - | pF |
| Output Capacitance | C_{oss} | | - | 230 | - | |
| Reverse Transfer Capacitance | C_{rss} | | - | 24 | - | |
| Total Gate Charge | Q_g | $V_{GS} = 10\text{ V}$, $I_D = 16\text{ A}$, $V_{DS} = 400\text{ V}$ | - | 45 | 68 | nC |
| Gate-Source Charge | Q_{gs} | | - | 18 | - | |
| Gate-Drain Charge | Q_{gd} | | - | 22 | - | |
| Turn-On Delay Time | $t_{d(on)}$ | $V_{DD} = 250\text{ V}$, $I_D = 16\text{ A}$, $R_g = 9.1\text{ }\Omega$, $V_{GS} = 10\text{ V}$ | - | 27 | - | ns |
| Rise Time | t_r | | - | 156 | - | |
| Turn-Off Delay Time | $t_{d(off)}$ | | - | 29 | - | |
| Fall Time | t_f | | - | 31 | - | |
| Gate Input Resistance | R_g | $f = 1\text{ MHz}$, open drain | - | 1.6 | - | Ω |
| Drain-Source Body Diode Characteristics | | | | | | |
| Continuous Source-Drain Diode Current | I_S | MOSFET symbol showing the integral reverse p - n junction diode  | - | - | 16 | A |
| Pulsed Diode Forward Current | I_{SM} | | - | - | 30 | |
| Body Diode Voltage | V_{SD} | $T_J = 25\text{ °C}$, $I_S = 10\text{ A}$, $V_{GS} = 0\text{ V}$ | - | - | 1.8 | V |
| Body Diode Reverse Recovery Time | t_{rr} | $T_J = 25\text{ °C}$, $I_F = I_S$, $dI/dt = 100\text{ A}/\mu\text{s}$, $V_R = 20\text{ V}$ | - | 555 | - | ns |
| Body Diode Reverse Recovery Charge | Q_{rr} | | - | 5.5 | - | μC |
| Body Diode Reverse Recovery Current | I_{RRM} | | - | 18 | - | A |

Note

- The information shown here is a preliminary product proposal, not a commercial product data sheet. Vishay Siliconix is not committed to produce this or any similar product. This information should not be used for design purposes, nor construed as an offer to furnish or sell such products.

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

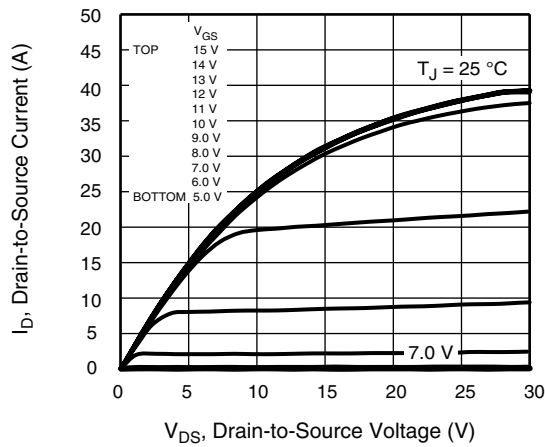


Fig. 1 - Typical Output Characteristics

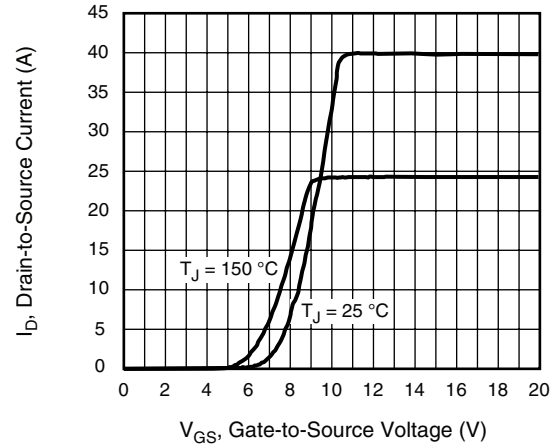


Fig. 3 - Typical Transfer Characteristics

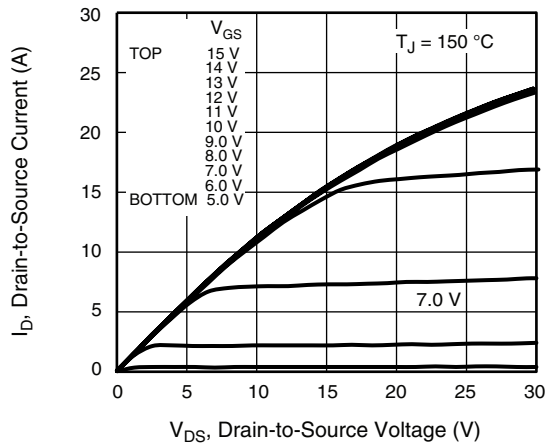


Fig. 2 - Typical Output Characteristics

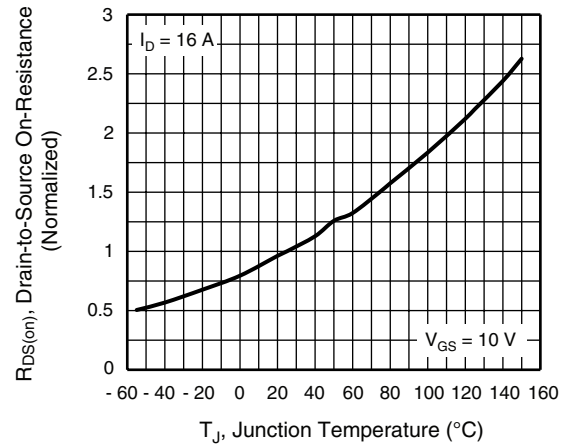


Fig. 4 - Normalized On-Resistance vs. Temperature

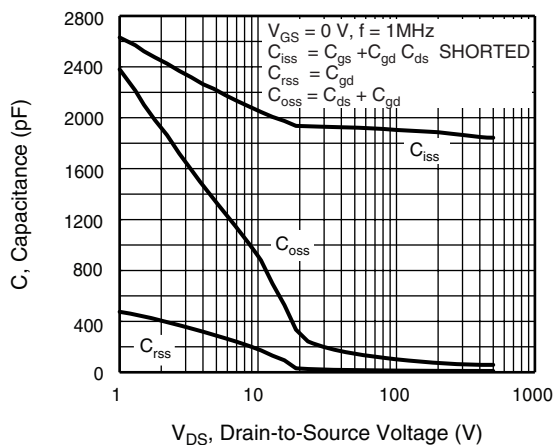


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

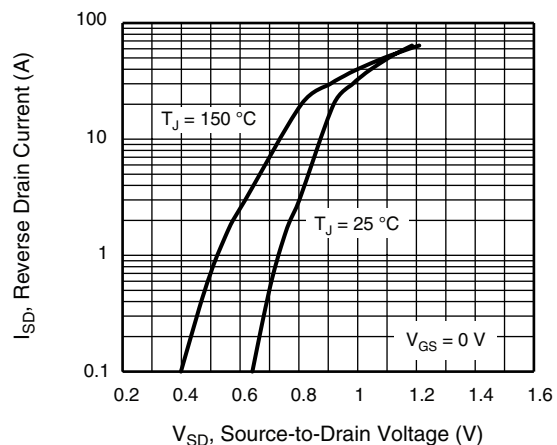


Fig. 7 - Typical Source-Drain Diode Forward Voltage

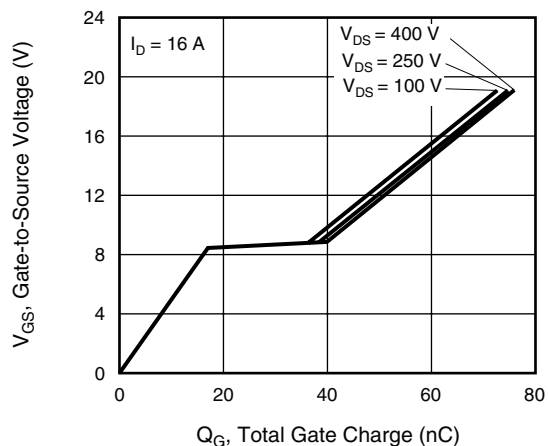


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

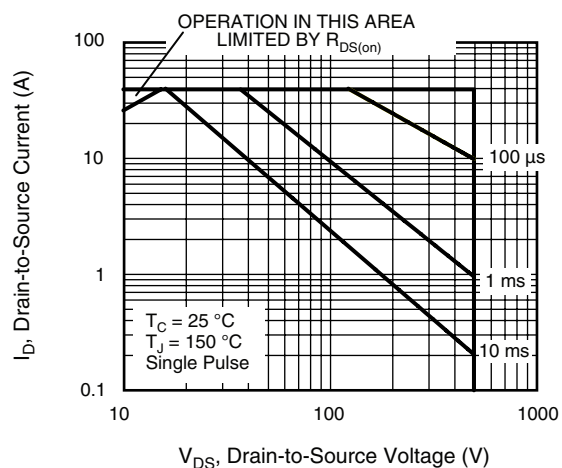


Fig. 8 - Maximum Safe Operating Area

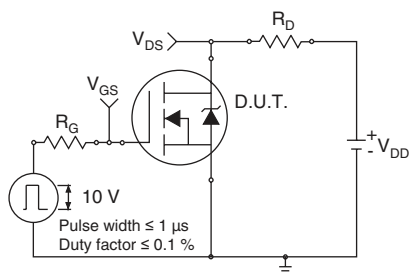


Fig. 9a - Switching Time Test Circuit

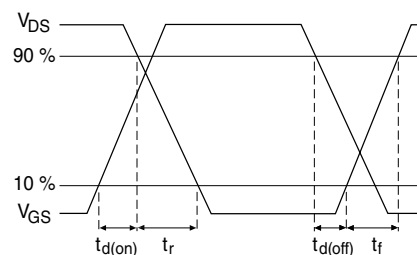


Fig. 9b - Switching Time Waveforms

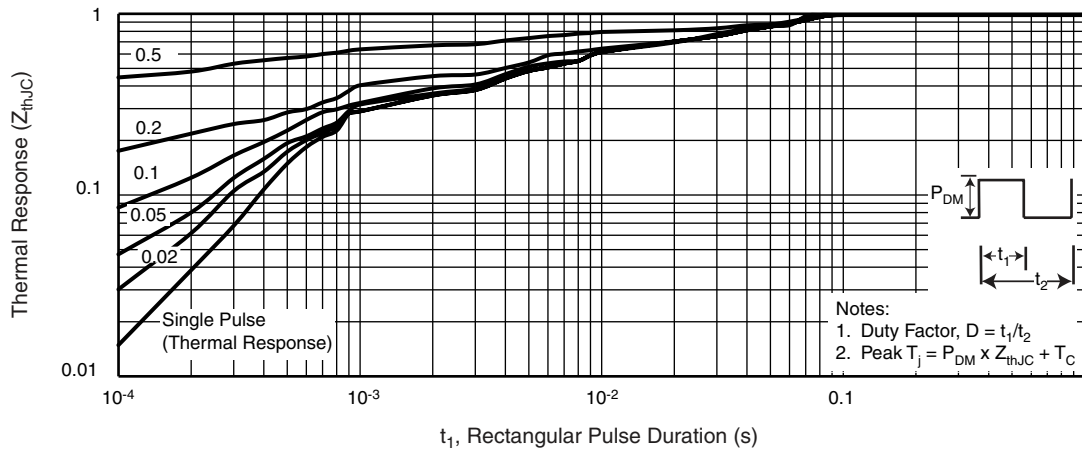


Fig. 10 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

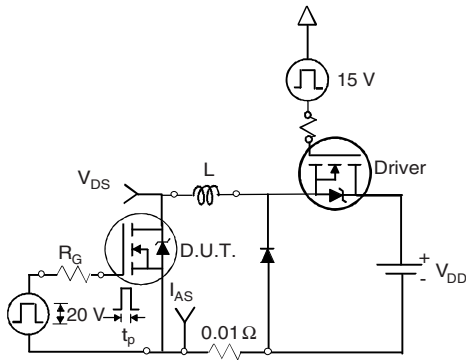


Fig. 11a - Unclamped Inductive Test Circuit

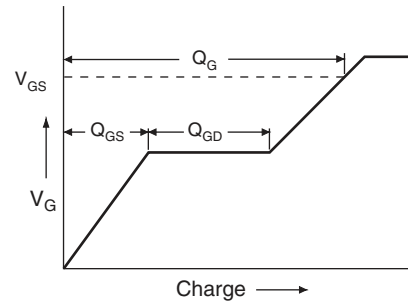


Fig. 12a - Basic Gate Charge Waveform

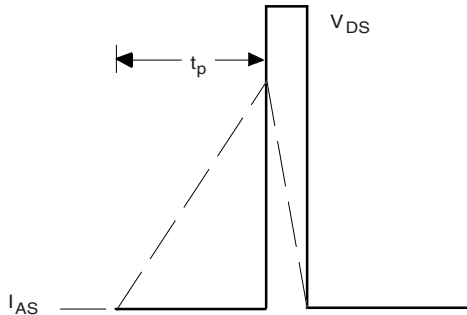


Fig. 11b - Unclamped Inductive Waveforms

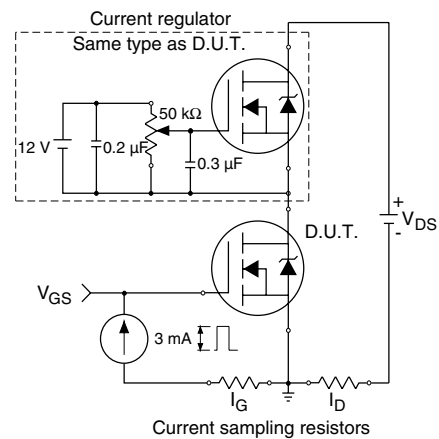
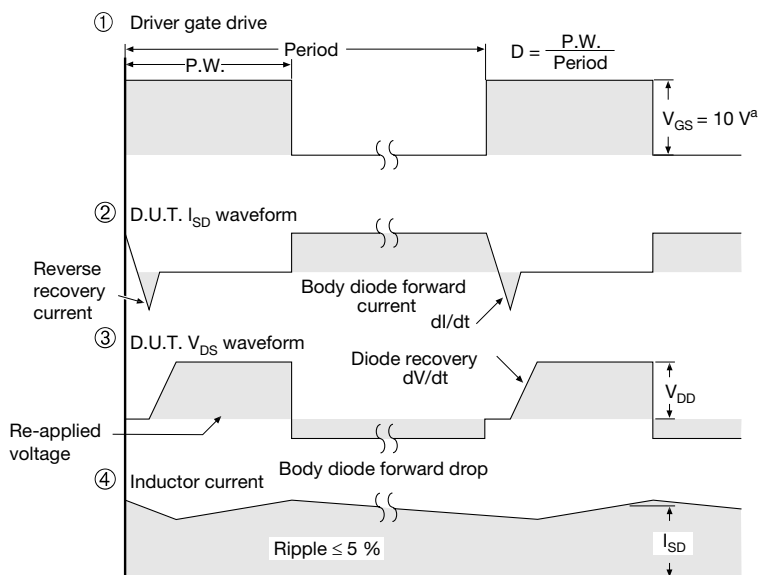
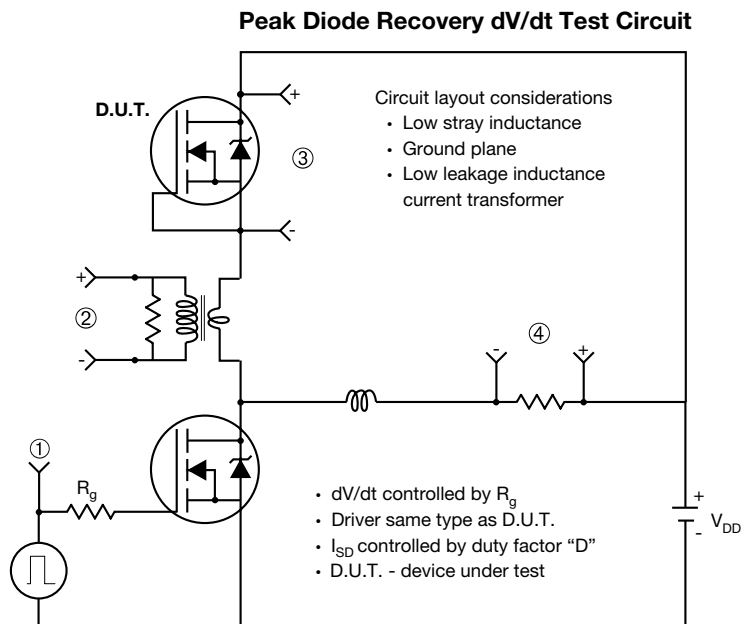


Fig. 12b - Gate Charge Test Circuit

**Note**

a. $V_{GS} = 5 V$ for logic level devices

Fig. 13 - For N-Channel

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